

# System Ready, 18-Bit ±0.5 LSB INL, Voltage Output DAC

## **Data Sheet**

### **FEATURES**

True 18-bit voltage output DAC, ±1 LSB INL 8 nV/√Hz output noise spectral density 0.025 LSB long-term linearity error stability ±0.018 ppm/°C gain error temperature coefficient 2.5 µs output voltage settling time 3.5 nV-sec midscale glitch impulse Integrated precision reference buffers Operating temperature range: -40°C to +125°C 4 mm × 5 mm LFCSP package Wide power supply range of up to ±16.5 V 35 MHz Schmitt triggered digital interface 1.8 V-compatible digital interface

#### **APPLICATIONS**

Medical instrumentation Test and measurement Industrial control Scientific and aerospace instrumentation Data acquisition systems Digital gain and offset adjustment Power supply control

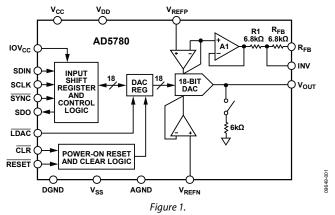
### **GENERAL DESCRIPTION**

The AD5780<sup>1</sup> is a true 18-bit, unbuffered voltage output DAC that operates from a bipolar supply of up to 33 V. The AD5780 accepts a positive reference input range of 5 V to  $V_{DD}$  – 2.5 V and a negative reference input range of  $V_{SS}$  + 2.5 V to 0 V. Both reference inputs are buffered on chip and external buffers are not required. The AD5780 offers a relative accuracy specification of ±1 LSB maximum range, and operation is guaranteed monotonic with a ±1 LSB DNL maximum range specification.

The part uses a versatile 3-wire serial interface that operates at clock rates of up to 35 MHz and is compatible with standard SPI, QSPI<sup>™</sup>, MICROWIRE<sup>™</sup>, and DSP interface standards. The part incorporates a power-on reset circuit that ensures that the DAC output powers up to 0 V in a known output impedance state and remains in this state until a valid write to the device takes place. The part provides an output clamp feature that places the output in a defined load state.

### FUNCTIONAL BLOCK DIAGRAM

**AD5780** 



#### Table 1. Related Devices

Part No.	Description
AD5790	20-bit, 2 LSB accurate DAC
AD5791	20-bit, 1 ppm accurate DAC
AD5781	18-bit, 0.5 LSB accurate DAC
AD5541A/AD5542A	16-bit, 1 LSB accurate 5 V DAC
AD5760	16-bit, 0.5 LSB accurate DAC

#### **PRODUCT HIGHLIGHTS**

- 1. True 18-bit accuracy.
- 2. Wide power supply range of up to  $\pm 16.5$  V.
- 3. -40°C to +125°C operating temperature range.
- 4. Low 8 nV/ $\sqrt{\text{Hz}}$  noise.
- 5. Low ±0.018 ppm/°C gain error temperature coefficient.

### **COMPANION PRODUCTS**

Output Amplifier Buffer: AD8675, ADA4898-1, ADA4004-1

External Reference: ADR445

DC-to-DC Design Tool: ADIsimPower™

Additional companion products on the AD5780 product page

<sup>1</sup> Protected by U.S. Patent No. 7,884,747.

#### Rev. B

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## **REVISION HISTORY**

2/12—Rev. A to Rev. B
Deleted Linearity Compensation Section
12/11—Rev. 0 to Rev. A
Edits to Table 2
Changes to Figure 4817
Changes to DAC Register Section
Changes to Table 10 and Table 11 22
11/11—Revision 0: Initial Version

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# **SPECIFICATIONS**

 $V_{DD}$  = 12.5 V to 16.5 V,  $V_{SS}$  = -16.5 V to -12.5 V,  $V_{REFP}$  = 10 V,  $V_{REFN}$  = -10 V,  $V_{CC}$  = 2.7 V to 5.5 V,  $IOV_{CC}$  = 1.71 V to 5.5 V,  $R_L$  = unloaded,  $C_L$  = unloaded,  $T_{MIN}$  to  $T_{MAX}$ , unless otherwise noted.

#### Table 2.

	A, B Versions <sup>1</sup>				
Parameter	Min	Тур	Max	Unit	<b>Test Conditions/Comments</b>
STATIC PERFORMANCE <sup>2</sup>					
Resolution	18			Bits	
Integral Nonlinearity Error (Relative Accuracy)	-0.85		+0.85	LSB	B grade, $V_{REFP} = +10 \text{ V}$ , $V_{REFN} = -10 \text{ V}$ , $T_A = 25^{\circ}\text{C}$
	-1		+1	LSB	B grade, $V_{REFx} = \pm 10 \text{ V}$ , $\pm 10 \text{ V}$ , and $\pm 5 \text{ V}$
	-2		+2	LSB	A grade, $V_{REFx} = \pm 10 \text{ V}$ , $\pm 10 \text{ V}$ , and $\pm 5 \text{ V}$
Differential Nonlinearity Error	-0.25		+0.75	LSB	B grade, $V_{REFx} = \pm 10 \text{ V}$ , +10 V, and +5 V
	-1		+1	LSB	A grade, $V_{REFx} = \pm 10 \text{ V}$ , +10 V, and +5 V
Long-Term Linearity Error Stability <sup>3</sup>		0.025		LSB	After 750 hours at $T_A = 135^{\circ}C$
Full-Scale Error	-3	±0.95	+3	LSB	$V_{REFP} = +10 \text{ V}, V_{REFN} = -10 \text{ V}$
	-5.5	±0.675	+0.5	LSB	$V_{\text{REFP}} = 10 \text{ V}, V_{\text{REFN}} = 0 \text{ V}$
	-10	±0.45	+10	LSB	$V_{REFP} = 5 V, V_{REFN} = 0 V$
Full-Scale Error Temperature Coefficient		±0.026		ppm/°C	$V_{REFP} = +10 \text{ V}, V_{REFN} = -10 \text{ V}$
Zero-Scale Error	-4.8	±0.325	+4.8	LSB	$V_{REFP} = +10 \text{ V}, V_{REFN} = -10 \text{ V}$
	-10	±0.175	+10	LSB	$V_{\text{REFP}} = 10 \text{ V}, V_{\text{REFN}} = 0 \text{ V}$
	-20.5	±0.225	+20.5	LSB	$V_{REFP} = 5 V, V_{REFN} = 0 V$
Zero-Scale Error Temperature Coefficient		±0.025		ppm/°C	$V_{REFP} = +10 \text{ V}, V_{REFN} = -10 \text{ V}$
Gain Error	-19	±2.3	+19	ppm FSR	$V_{REFP} = +10 \text{ V}, V_{REFN} = -10 \text{ V}$
	-35	±1.9	+35	ppm FSR	$V_{\text{REFP}} = 10 \text{ V}, V_{\text{REFN}} = 0 \text{ V}$
	-68	±0.9	+68	ppm FSR	$V_{REFP} = 5 V, V_{REFN} = 0 V$
Gain Error Temperature Coefficient		±0.018		ppm/°C	$V_{REFP} = +10 \text{ V}, V_{REFN} = -10 \text{ V}$
R1, R <sub>FB</sub> Matching		0.015		%	
OUTPUT CHARACTERISTICS					
Output Voltage Range	VREFN		VREFP	V	
Output Voltage Settling Time		2.5		μs	10 V step to 0.02%, using the ADA4898-1 buffer in unity-gain mode
		3.5		μs	500 code step to $\pm 1 \text{ LSB}^4$
Output Noise Spectral Density		8		nV/√Hz	At 1 kHz, DAC code = midscale
		8		nV/√Hz	At 10 kHz, DAC code = midscale
Output Voltage Noise		1.1		μV p-р	DAC code = midscale, 0.1 Hz to 10 Hz bandwidth
Midscale Glitch Impulse <sup>4</sup>		14		nV-sec	$V_{REFP} = +10 \text{ V}, V_{REFN} = -10 \text{ V}$
·		3.5		nV-sec	$V_{REFP} = 10 \text{ V},  V_{REFN} = 0 \text{ V}$
		4		nV-sec	$V_{\text{REFP}} = 5 \text{ V}, V_{\text{REFN}} = 0 \text{ V}$
MSB Segment Glitch Impulse <sup>4</sup>		14		nV-sec	$V_{\text{REFP}} = +10 \text{ V}, V_{\text{REFN}} = -10 \text{ V}, \text{ see Figure 43}$
		3.5		nV-sec	$V_{\text{REFP}} = 10 \text{ V}, V_{\text{REFN}} = 0 \text{ V}, \text{ see Figure 44}$
		4		nV-sec	$V_{REFP} = 5 V$ , $V_{REFN} = 0 V$ , see Figure 45
Output Enabled Glitch Impulse		57		nV-sec	On removal of output ground clamp
Digital Feedthrough		0.27		nV-sec	
DC Output Impedance (Normal Mode)		3.4		kΩ	
DC Output Impedance (Normal Mode) DC Output Impedance (Output Clamped to Ground)		3.4 6		kΩ	

# AD5780

	A, B Versions <sup>1</sup>				
Parameter	Min	Тур	Max	Unit	Test Conditions/Comments
REFERENCE INPUTS					
VREFP Input Range	5		$V_{\text{DD}} - 2.5$	V	
V <sub>REFN</sub> Input Range	V <sub>ss</sub> + 2.5		0	V	
Input Bias Current	-20	-0.63	+20	nA	
	-4	-0.63	+4		$T_A = 0^{\circ}C$ to $105^{\circ}C$
Input Capacitance		1		рF	VREFP, VREFN
LOGIC INPUTS					
Input Current⁵	-1		+1	μA	
Input Low Voltage, V <sub>IL</sub>			$0.3 \times IOV_{CC}$	V	IOV <sub>cc</sub> = 1.71 V to 5.5 V
Input High Voltage, V⊩	$0.7 \times IOV_{CC}$			V	IOV <sub>cc</sub> = 1.71 V to 5.5 V
Pin Capacitance		5		pF	
LOGIC OUTPUT (SDO)				-	
Output Low Voltage, Vol			0.4	V	$IOV_{cc} = 1.71 V$ to 5.5 V, sinking 1 mA
Output High Voltage, V <sub>он</sub>	$IOV_{CC} - 0.5$			V	$IOV_{cc} = 1.71 V$ to 5.5 V, sourcing 1 mA
High Impedance Leakage Current			±1	μA	
High Impedance Output Capacitance		3		pF	
POWER REQUIREMENTS				-	All digital inputs at DGND or IOV <sub>cc</sub>
V <sub>DD</sub>	7.5		Vss + 33	V	
Vss	V <sub>DD</sub> - 33		-2.5	V	
Vcc	2.7		5.5	V	
IOVcc	1.71		5.5	V	IOVcc ≤ Vcc
I <sub>DD</sub>		10.3	14	mA	
lss		-10	-14	mA	
lcc		600	900	μA	
IOIcc		52	140	μA	SDO disabled
DC Power Supply Rejection Ratio		±7.5		μV/V	$\Delta V_{DD} \pm 10\%, V_{SS} = -15 V$
		±1.5		μV/V	$\Delta V_{\rm SS} \pm 10\%, V_{\rm DD} = 15  \rm V$
AC Power Supply Rejection Ratio		90		dB	$\Delta V_{DD} \pm 200 \text{ mV}$ , 50 Hz/60 Hz, V <sub>ss</sub> = -15 V
		90		dB	$\Delta V_{ss} \pm 200 \text{ mV}$ , 50 Hz/60 Hz, V <sub>DD</sub> = 15 V

<sup>1</sup> Temperature range:  $-40^{\circ}$ C to  $+125^{\circ}$ C, typical conditions:  $T_A = 25^{\circ}$ C,  $V_{DD} = +15$  V,  $V_{SS} = -15$  V,  $V_{REFP} = +10$  V,  $V_{REFN} = -10$  V. <sup>2</sup> Performance characterized with the AD8675ARZ output buffer. <sup>3</sup> Linearity error refers to both INL error and DNL error, either parameter can be expected to drift by the amount specified after the length of time specified. <sup>4</sup> The AD5780 is configured in the unity-gain mode with a low-pass RC filter on the output. R = 300  $\Omega$ , C = 143 pF (total capacitance seen by the output buffer, lead capacitance, and so forth). <sup>5</sup> Current flowing in an individual logic pin.

## **TIMING CHARACTERISTICS**

 $V_{\rm CC}$  = 2.7 V to 5.5 V; all specifications  $T_{\rm MIN}$  to  $T_{\rm MAX}$ , unless otherwise noted.

#### Table 3.

	Lim	it <sup>1</sup>		
Parameter	IOV <sub>cc</sub> = 1.71 V to 3.3 V	IOV <sub>cc</sub> = 3.3 V to 5.5 V	Unit	Test Conditions/Comments
t1 <sup>2</sup>	40	28	ns min	SCLK cycle time
	92	60	ns min	SCLK cycle time (readback and daisy-chain modes)
<b>t</b> <sub>2</sub>	15	10	ns min	SCLK high time
t <sub>3</sub>	9	5	ns min	SCLK low time
t4	5	5	ns min	SYNC to SCLK falling edge setup time
t₅	2	2	ns min	SCLK falling edge to SYNC rising edge hold time
t <sub>6</sub>	48	40	ns min	Minimum SYNC high time
t7	8	6	ns min	SYNC rising edge to next SCLK falling edge ignore
t <sub>8</sub>	9	7	ns min	Data setup time
t9	12	7	ns min	Data hold time
t <sub>10</sub>	13	10	ns min	LDAC falling edge to SYNC falling edge
t <sub>11</sub>	20	16	ns min	SYNC rising edge to LDAC falling edge
t <sub>12</sub>	14	11	ns min	LDAC pulse width low
<b>t</b> <sub>13</sub>	130	130	ns typ	LDAC falling edge to output response time
t <sub>14</sub>	130	130	ns typ	SYNC rising edge to output response time (LDAC tied low)
t <sub>15</sub>	50	50	ns min	CLR pulse width low
t <sub>16</sub>	140	140	ns typ	CLR pulse activation time
t <sub>17</sub>	0	0	ns min	SYNC falling edge to first SCLK rising edge
t <sub>18</sub>	65	60	ns max	$\overline{\text{SYNC}}$ rising edge to SDO tristate (C <sub>L</sub> = 50 pF)
t <sub>19</sub>	62	45	ns max	SCLK rising edge to SDO valid ( $C_L = 50 \text{ pF}$ )
t <sub>20</sub>	0	0	ns min	SYNC rising edge to SCLK rising edge ignore
<b>t</b> <sub>21</sub>	35	35	ns typ	RESET pulse width low
t <sub>22</sub>	150	150	ns typ	RESET pulse activation time

<sup>1</sup> All input signals are specified with  $t_R = t_F = 1 \text{ ns/V}$  (10% to 90% of IOV<sub>cc</sub>) and timed from a voltage level of ( $V_{IL} + V_{IH}$ )/2. <sup>2</sup> Maximum SCLK frequency is 35 MHz for write mode and 16 MHz for readback and daisy-chain modes.

# AD5780

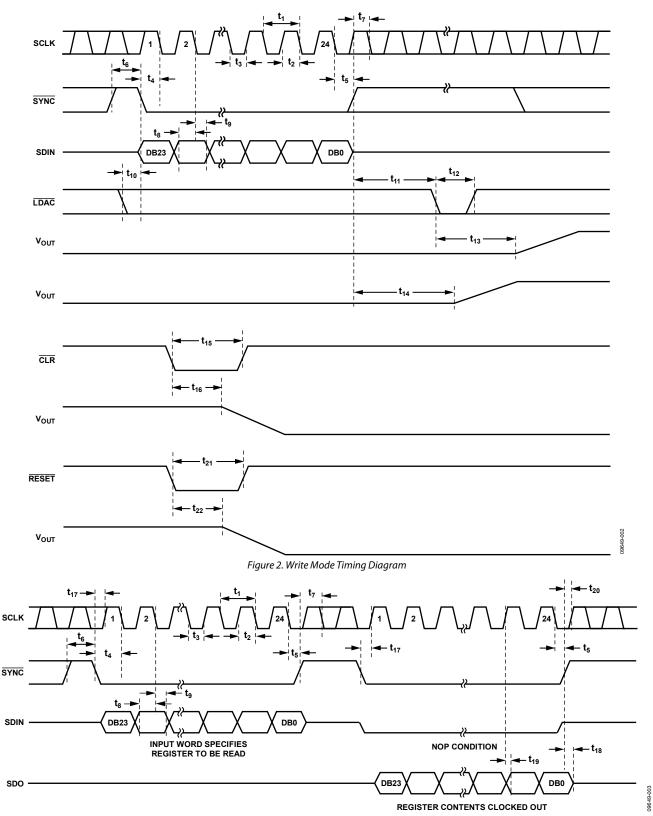


Figure 3. Readback Mode Timing Diagram

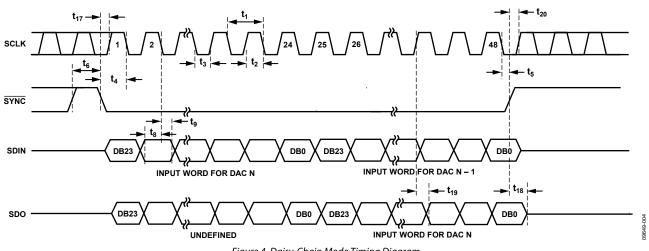


Figure 4. Daisy-Chain Mode Timing Diagram

## **ABSOLUTE MAXIMUM RATINGS**

 $T_A = 25$ °C, unless otherwise noted. Transient currents of up to 100 mA do not cause SCR latch-up.

#### Table 4.

Parameter	Rating
V <sub>DD</sub> to AGND	-0.3 V to +34 V
Vss to AGND	-34 V to +0.3 V
V <sub>DD</sub> to V <sub>SS</sub>	–0.3 V to +34 V
V <sub>CC</sub> to DGND	–0.3 V to +7 V
IOV <sub>cc</sub> to DGND	-0.3 V to V <sub>cc</sub> + 3 V or +7 V (whichever is less)
Digital Inputs to DGND	-0.3 V to IOV <sub>CC</sub> + 0.3 V or +7 V (whichever is less)
Vout to AGND	-0.3 V to V <sub>DD</sub> + 0.3 V
VREFP to AGND	-0.3 V to V <sub>DD</sub> + 0.3 V
V <sub>REFN</sub> to AGND	$V_{SS} - 0.3 V$ to +0.3 V
DGND to AGND	–0.3 V to +0.3 V
Operating Temperature Range, T <sub>A</sub>	
Industrial	–40°C to +125°C
Storage Temperature Range	–65°C to +150°C
Maximum Junction Temperature, TJ max	150°C
Power Dissipation	$(T_J max - T_A)/\theta_{JA}$
LFCSP Package	
$\theta_{JA}$ Thermal Impedance	31.0°C/W
Lead Temperature	JEDEC industry standard
Soldering	J-STD-020
ESD (Human Body Model)	1.6 kV

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

This device is a high performance integrated circuit with an ESD rating of 1.6 kV, and it is ESD sensitive. Proper precautions must be taken for handling and assembly.

#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

# **PIN CONFIGURATION AND FUNCTION DESCRIPTIONS**

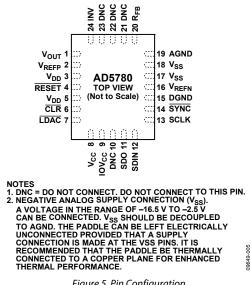


Figure 5. Pin Configuration

#### **Table 5. Pin Function Descriptions**

Pin No.	Mnemonic	Description
1	Vout	Analog Output Voltage.
2	VREFP	Positive Reference Voltage Input. A voltage in the range of 5 V to $V_{DD}$ – 2.5 V can be connected to this pin.
3, 5	V <sub>DD</sub>	Positive Analog Supply Connection. A voltage in the range of 7.5 V to 16.5 V can be connected to this pin. V <sub>DD</sub> must be decoupled to AGND.
4	RESET	Active Low Reset. Asserting this pin returns the AD5780 to its power-on status.
6	CLR	Active Low Input. Asserting this pin sets the DAC register to a user defined value (see Table 12) and updates the DAC output. The output value depends on the DAC register coding that is being used, either binary or twos complement.
7	LDAC	Active Low Load DAC Logic Input. This pin is used to update the DAC register and, consequently, the analog output. When tied permanently low, the output is updated on the rising edge of SYNC. If LDAC is held high during the write cycle, the input register is updated, but the output update is held off until the falling edge of LDAC. Do not leave the LDAC pin unconnected.
8	Vcc	Digital Supply. Voltage range is from 2.7 V to 5.5 V. $V_{cc}$ should be decoupled to DGND.
9	IOV <sub>CC</sub>	Digital Interface Supply. Digital threshold levels are referenced to the voltage applied to this pin. Voltage range is from 1.71 V to 5.5 V.
10, 21, 22, 23	DNC	Do Not Connect. Do not connect to these pins.
11	SDO	Serial Data Output.
12	SDIN	Serial Data Input. This device has a 24-bit input shift register. Data is clocked into the register on the falling edge of the serial clock input.
13	SCLK	Serial Clock Input. Data is clocked into the input shift register on the falling edge of the serial clock input. Data can be transferred at rates of up to 35 MHz.
14	SYNC	Level Triggered Control Input (Active Low). This is the frame synchronization signal for the input data. When SYNC goes low, it enables the input shift register, and data is then transferred in on the falling edges of the following clocks. The DAC is updated on the rising edge of SYNC.
15	DGND	Ground Reference Pin for Digital Circuitry.
16	VREFN	Negative Reference Voltage Input.
17, 18	Vss	Negative Analog Supply Connection. A voltage in the range of $-16.5$ V to $-2.5$ V can be connected to this pin. V <sub>ss</sub> must be decoupled to AGND.
19	AGND	Ground Reference Pin for Analog Circuitry.
20	R <sub>FB</sub>	Feedback Connection for External Amplifier. See the AD5780 Features section for further details.
24	INV	Inverting Input Connection for External Amplifier. See the AD5780 Features section for further details.
EPAD	Vss	Negative Analog Supply Connection ( $V_{SS}$ ). A voltage in the range of $-16.5$ V to $-2.5$ V can be connected to this pin. $V_{SS}$ must be decoupled to AGND. The paddle can be left electrically unconnected provided that a supply connection is made at the $V_{SS}$ pins. It is recommended that the paddle be thermally connected to a copper plane for enhanced thermal performance.

## **TYPICAL PERFORMANCE CHARACTERISTICS**

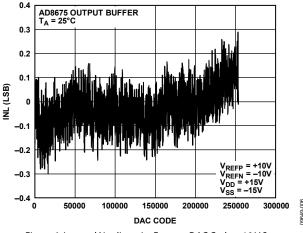
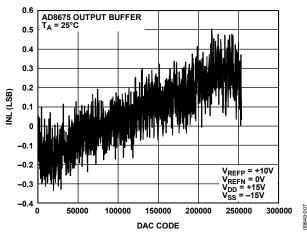
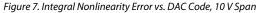
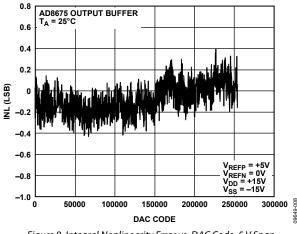
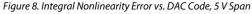


Figure 6. Integral Nonlinearity Error vs. DAC Code,  $\pm 10$  V Span









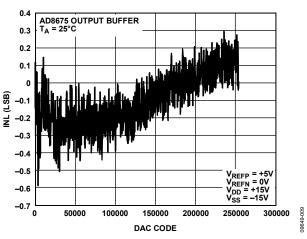
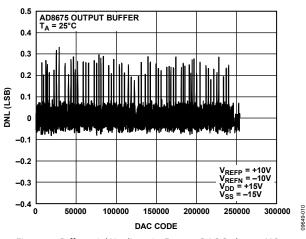


Figure 9. Integral Nonlinearity Error vs. DAC Code, 5 V Span,  $\times 2$  Gain Mode



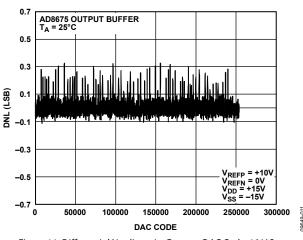
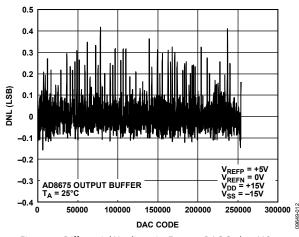


Figure 10. Differential Nonlinearity Error vs. DAC Code,  $\pm 10$  V Span

Figure 11. Differential Nonlinearity Error vs. DAC Code, 10 V Span

# AD5780



#### Figure 12. Differential Nonlinearity Error vs. DAC Code, 5 V Span

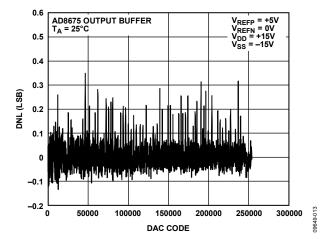
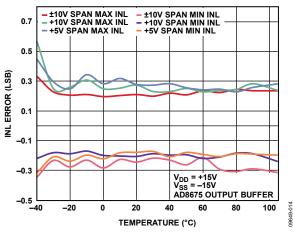
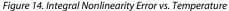
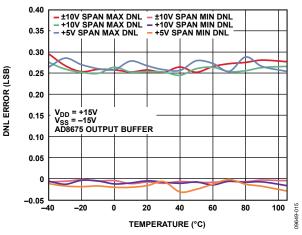


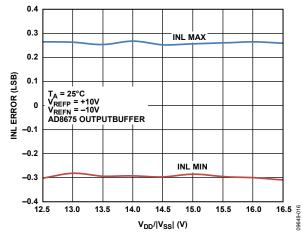
Figure 13. Differential Nonlinearity Error vs. DAC Code, 5 V Span, ×2 Gain Mode

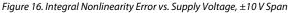












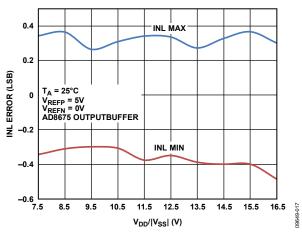
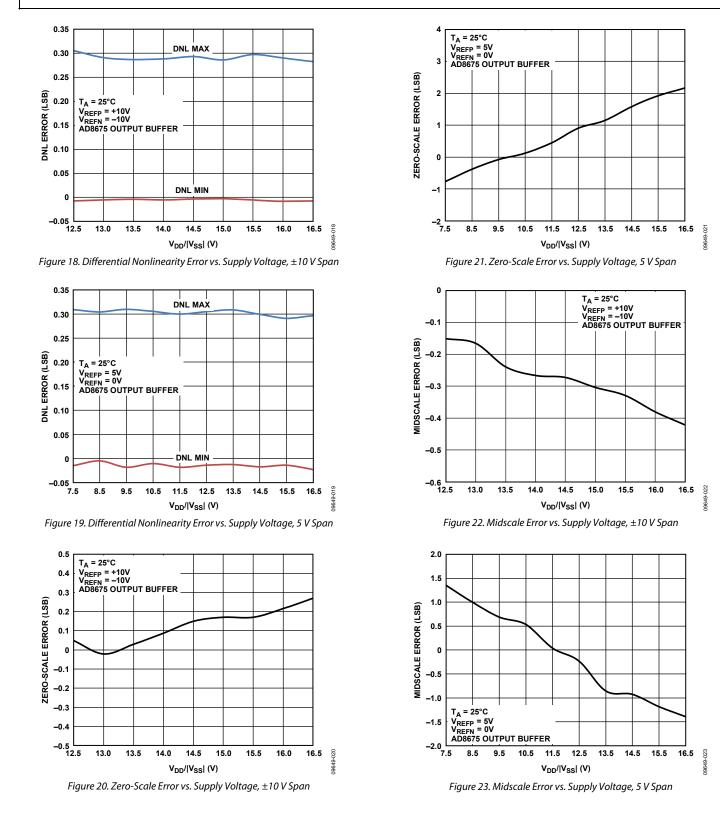
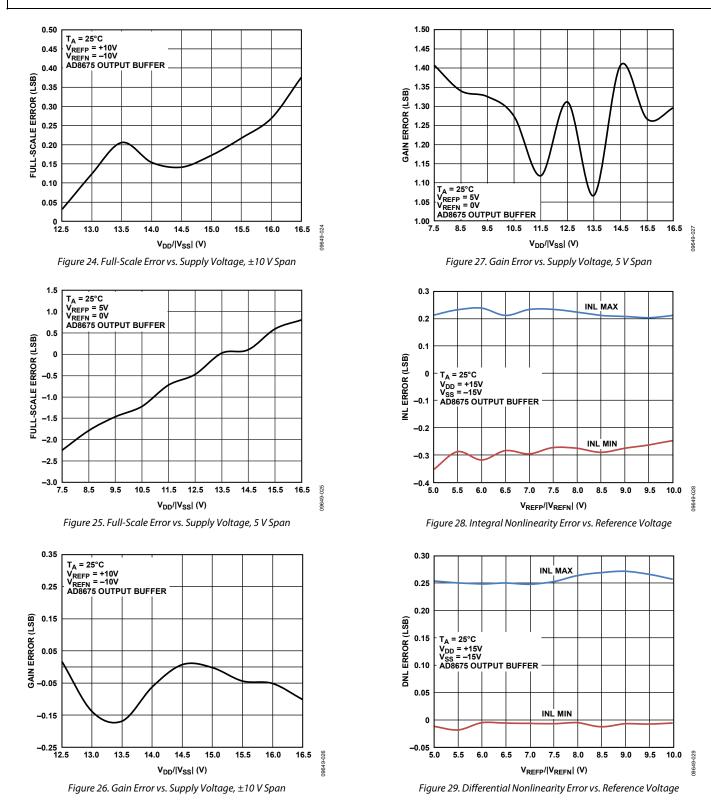


Figure 17. Integral Nonlinearity Error vs. Supply Voltage, 5 V Span

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# AD5780

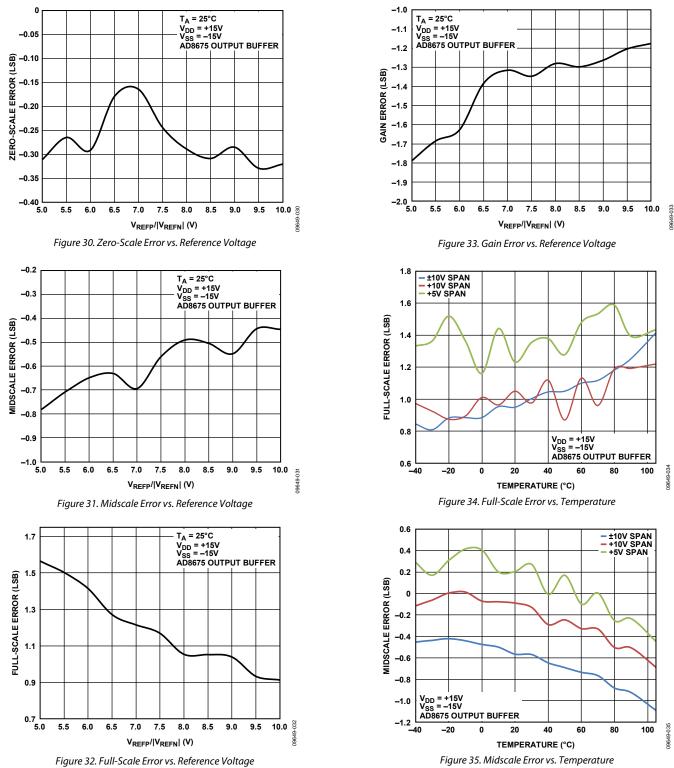
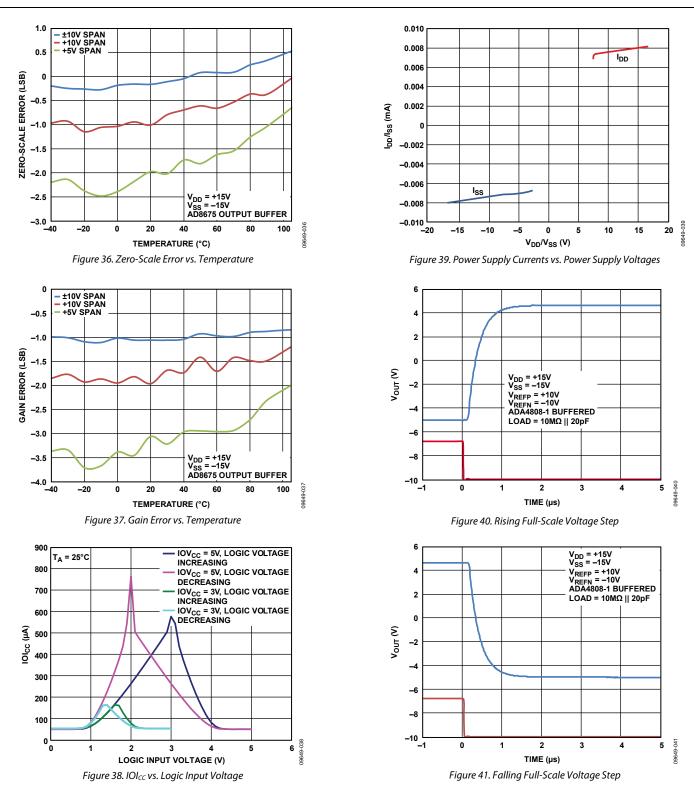
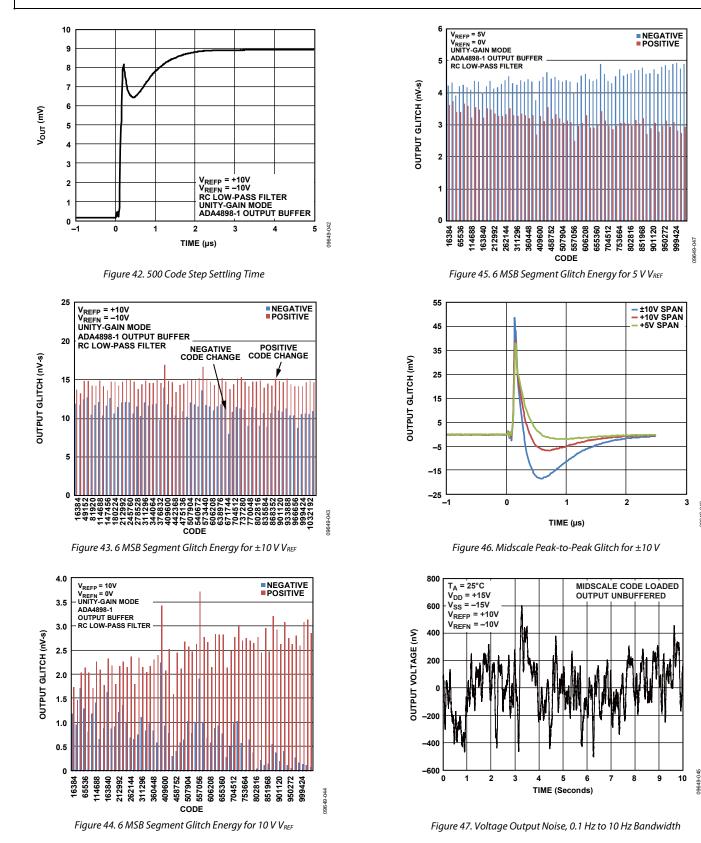


Figure 35. Midscale Error vs. Temperature

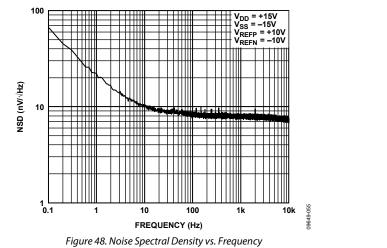


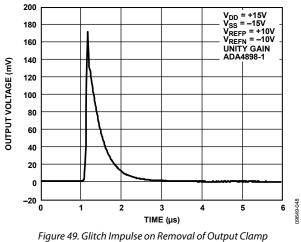
# AD5780

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# AD5780





# TERMINOLOGY

#### **Relative Accuracy**

Relative accuracy, or integral nonlinearity (INL), is a measure of the maximum deviation, in LSB, from a straight line passing through the endpoints of the DAC transfer function. A typical INL error vs. code plot is shown in Figure 6.

#### Differential Nonlinearity (DNL)

Differential nonlinearity is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of  $\pm 1$  LSB maximum ensures monotonicity. This DAC is guaranteed monotonic. A typical DNL error vs. code plot is shown in Figure 10.

#### Linearity Error Long-Term Stability

Linearity error long-term stability is a measure of the stability of the linearity of the DAC over a long period of time. It is specified in LSB for a time period of 500 hours and 1000 hours at an elevated ambient temperature.

#### Zero-Scale Error

Zero-scale error is a measure of the output error when zero-scale code (0x00000) is loaded to the DAC register. Ideally, the output voltage should be V<sub>REFN</sub>. Zero-scale error is expressed in LSBs.

#### Zero-Scale Error Temperature Coefficient

Zero-scale error temperature coefficient is a measure of the change in zero-scale error with a change in temperature. It is expressed in ppm FSR/°C.

#### **Full-Scale Error**

Full-scale error is a measure of the output error when full-scale code (0x3FFFF) is loaded to the DAC register. Ideally, the output voltage should be  $V_{REFP} - 1$  LSB. Full-scale error is expressed in LSBs.

#### **Full-Scale Error Temperature Coefficient**

Full-scale error temperature coefficient is a measure of the change in full-scale error with a change in temperature. It is expressed in ppm FSR/°C.

#### **Gain Error**

Gain error is a measure of the span error of the DAC. It is the deviation in slope of the DAC transfer characteristic from the ideal, expressed in ppm of the full-scale range.

#### **Gain Error Temperature Coefficient**

Gain error temperature coefficient is a measure of the change in gain error with a change in temperature. It is expressed in ppm FSR/°C.

#### **Midscale Error**

Midscale error is a measure of the output error when midscale code (0x20000) is loaded to the DAC register. Ideally, the output voltage should be  $(V_{REFP} - V_{REFN})/2 + V_{REFN}$ . Midscale error is expressed in LSBs.

#### **Output Voltage Settling Time**

Output voltage settling time is the amount of time it takes for the output voltage to settle to a specified level for a specified change in voltage. For fast settling applications, a high speed buffer amplifier is required to buffer the load from the  $3.4 \text{ k}\Omega$ output impedance of the AD5780, in which case, it is the amplifier that determines the settling time.

#### Digital-to-Analog Glitch Impulse

Digital-to-analog glitch impulse is the impulse injected into the analog output when the input code in the DAC register changes state. It is specified as the area of the glitch in nV-sec and is measured when the digital input code is changed by 1 LSB at the major carry transition (see Figure 49).

#### **Output Enabled Glitch Impulse**

Output enabled glitch impulse is the impulse injected into the analog output when the clamp to ground on the DAC output is removed. It is specified as the area of the glitch in nV-sec (see Figure 49).

#### **Digital Feedthrough**

Digital feedthrough is a measure of the impulse injected into the analog output of the DAC from the digital inputs of the DAC but is measured when the DAC output is not updated. It is specified in nV-sec and measured with a full-scale code change on the data bus, that is, from all 0s to all 1s, and vice versa.

#### **Total Harmonic Distortion (THD)**

Total harmonic distortion is the ratio of the rms sum of the harmonics of the DAC output to the fundamental value. Only the second to fifth harmonics are included.

#### **DC** Power Supply Rejection Ratio

DC power supply rejection ratio is a measure of the rejection of the output voltage to dc changes in the power supplies applied to the DAC. It is measured for a given dc change in power supply voltage and is expressed in  $\mu$ V/V.

#### AC Power Supply Rejection Ratio (AC PSRR)

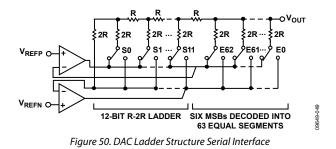
AC power supply rejection ratio is a measure of the rejection of the output voltage to ac changes in the power supplies applied to the DAC. It is measured for a given amplitude and frequency change in power supply voltage and is expressed in decibels.

# THEORY OF OPERATION

The AD5780 is a high accuracy, fast settling, single, 18-bit, serial input, voltage output DAC. It operates from a V<sub>DD</sub> supply voltage of 7.5 V to 16.5 V and a V<sub>SS</sub> supply of -16.5 V to -2.5 V. Data is written to the AD5780 in a 24-bit word format via a 3-wire serial interface. The AD5780 incorporates a power-on reset circuit that ensures the DAC output powers up to 0 V with the V<sub>OUT</sub> pin clamped to AGND through a ~6 k $\Omega$  internal resistor.

## DAC ARCHITECTURE

The architecture of the AD5780 consists of two matched DAC sections. A simplified circuit diagram is shown in Figure 50. The six MSBs of the 18-bit data-word are decoded to drive 63 switches, E0 to E62. Each of these switches connects one of 63 matched resistors to either the buffered  $V_{REFP}$  or buffered  $V_{REFN}$  voltage. The remaining 12 bits of the data-word drive the S0 to S11 switches of a 12-bit voltage mode R-2R ladder network.



### SERIAL INTERFACE

The AD5780 has a 3-wire serial interface  $\overline{(SYNC, SCLK, and SDIN)}$  that is compatible with SPI, QSPI, and MICROWIRE interface standards, as well as most DSPs (see Figure 2 for a timing diagram).

#### Input Shift Register

The input shift register is 24 bits wide. Data is loaded into the device MSB first as a 24-bit word under the control of a serial clock input, SCLK, which can operate at up to 35 MHz. The input register consists of a  $R/\overline{W}$  bit, three address bits, and 20 data bits as shown in Table 6. The timing diagram for this operation is shown in Figure 2.

# Table 6. Input Shift Register Format

MSB				LSB
DB23	DB22	DB21	DB20	DB19 to DB0
R/W		Register address		Register data

#### Table 7. Decoding the Input Shift Register

R/W	Register Address		ddress	Description
X <sup>1</sup>	0	0	0	No operation (NOP). Used in readback operations.
0	0	0	1	Write to the DAC register.
0	0	1	0	Write to the control register.
0	0	1	1	Write to the clearcode register.
0	1	0	0	Write to the software control register.
1	0	0	1	Read from the DAC register.
1	0	1	0	Read from the control register.
1	0	1	1	Read from the clearcode register.

<sup>1</sup> X is don't care.

#### **Standalone Operation**

The serial interface works with both a continuous and noncontinuous serial clock. A continuous SCLK source can be used only if <u>SYNC</u> is held low for the correct number of clock cycles.

In gated clock mode, a burst clock containing the exact number of clock cycles must be used, and SYNC must be taken high after the final clock to latch the data. The first falling edge of SYNC starts the write cycle. Exactly 24 falling clock edges must be applied to SCLK before SYNC is brought high again. If SYNC is brought high before the 24<sup>th</sup> falling SCLK edge, the data written is invalid. If more than 24 falling SCLK edges are applied before SYNC is brought high, the input data is also invalid.

The input shift register is updated on the rising edge of  $\overline{\text{SYNC}}$ . For another serial transfer to take place,  $\overline{\text{SYNC}}$  must be brought low again. After the end of the serial data transfer, data is automatically transferred from the input shift register to the addressed register. When the write cycle is complete, the output can be updated by taking  $\overline{\text{LDAC}}$  low while  $\overline{\text{SYNC}}$  is high.

#### **Daisy-Chain Operation**

For systems that contain several devices, the SDO pin can be used to daisy-chain several devices together. Daisy-chain mode can be useful in system diagnostics and in reducing the number of serial interface lines. The first falling edge of SYNC starts the write cycle. SCLK is continuously applied to the input shift register when  $\overline{\text{SYNC}}$  is low. If more than 24 clock pulses are applied, the data ripples out of the shift register and appears on the SDO line. This data is clocked out on the rising edge of SCLK and is valid on the falling edge. By connecting the SDO of the first device to the SDIN input of the next device in the chain, a multidevice interface is constructed. Each device in the system requires 24 clock pulses. Therefore, the total number of clock cycles must equal  $24 \times N$ , where N is the total number of AD5780 devices in the chain. When the serial transfer to all devices is complete, SYNC is taken high. This latches the input data in each device in the daisy chain and prevents any further data from being clocked into the input shift register. The serial clock can be a continuous or a gated clock.

A continuous SCLK source can be used only if <u>SYNC</u> is held low for the correct number of clock cycles. In gated clock mode, a burst clock containing the exact number of clock cycles must be used, and <u>SYNC</u> must be taken high after the final clock to latch the data.

In any one daisy-chain sequence, do not mix writes to the DAC register with writes to any of the other registers. All writes to the daisy-chained parts must be either writes to the DAC registers or writes to the control, clearcode, or software control register.

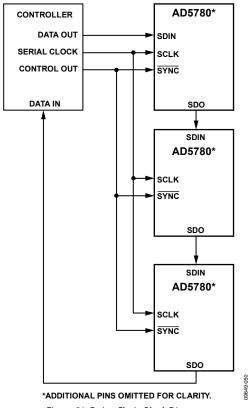


Figure 51. Daisy-Chain Block Diagram

#### Readback

The contents of all the on-chip registers can be read back via the SDO pin. Table 7 outlines how the registers are decoded. After a register has been addressed for a read, the next 24 clock cycles clock the data out on the SDO pin. The clocks must be applied while SYNC is low. When SYNC is returned high, the SDO pin is placed in tristate. For a read of a single register, the NOP function can be used to clock out the data. Alternatively, if more than one register is to be read, the data of the first register to be addressed can be clocked out at the same time that the second register to be read is being addressed. The SDO pin must be enabled to complete a readback operation. The SDO pin is enabled by default.

## HARDWARE CONTROL PINS Load DAC Function (LDAC)

After data has been transferred into the input register of the DAC, there are two ways to update the DAC register and DAC output. Depending on the status of both  $\overline{\text{SYNC}}$  and  $\overline{\text{LDAC}}$ , one of two update modes is selected: synchronous DAC update or asynchronous DAC update.

### Synchronous DAC Update

In this mode,  $\overline{\text{LDAC}}$  is held low while data is being clocked into the input shift register. The DAC output is updated on the rising edge of SYNC.

### Asynchronous DAC Update

In this mode,  $\overline{\text{LDAC}}$  is held high while data is being clocked into the input shift register. The DAC output is asynchronously updated by taking  $\overline{\text{LDAC}}$  low after  $\overline{\text{SYNC}}$  has been taken high. The update now occurs on the falling edge of  $\overline{\text{LDAC}}$ .

### Reset Function (RESET)

The AD5780 can be reset to its power-on state by two means: either by asserting the  $\overline{\text{RESET}}$  pin or by using the reset function in the software control register (see Table 13). If the  $\overline{\text{RESET}}$  pin is not used, hardwire it to IOV<sub>CC</sub>.

### Asynchronous Clear Function (CLR)

**Table 8. Hardware Control Pins Truth Table** 

The  $\overline{\text{CLR}}$  pin is an active low clear that allows the output to be cleared to a user defined value. The 18-bit clearcode value is programmed to the clearcode register (see Table 12). It is necessary to maintain  $\overline{\text{CLR}}$  low for a minimum amount of time to complete the operation (see Figure 2). When the  $\overline{\text{CLR}}$  signal is returned high, the output remains at the clear value (if  $\overline{\text{LDAC}}$ 

is high) until a new value is loaded to the DAC register. The output cannot be updated with a new value while the  $\overline{\text{CLR}}$  pin is low. A clear operation can also be performed by setting the CLR bit in the software control register (see Table 13).

## **ON-CHIP REGISTERS**

#### DAC Register

Table 9 outlines how data is written to and read from the DAC register.

The following equation describes the ideal transfer function of the DAC:

$$V_{OUT} = \frac{\left(V_{REFP} - V_{REFN}\right) \times D}{2^{18}} + V_{REFN}$$

where:

 $V_{REFN}$  is the negative voltage applied at the V<sub>REFN</sub> input pin.  $V_{REFP}$  is the positive voltage applied at the V<sub>REFP</sub> input pin. *D* is the 18-bit code programmed to the DAC.

LDAC	CLR	RESET	Function
<b>X</b> <sup>1</sup>	<b>X</b> <sup>1</sup>	0	The AD5780 is in reset mode. The device cannot be programmed.
<b>X</b> <sup>1</sup>	<b>X</b> <sup>1</sup>	t	The AD5780 is returned to its power-on state. All registers are set to their default values.
0	0	1	The DAC register is loaded with the clearcode register value, and the output is set accordingly.
0	1	1	The output is set according to the DAC register value.
1	0	1	The DAC register is loaded with the clearcode register value, and the output is set accordingly.
ļ	1	1	The output is set according to the DAC register value.
ļ	0	1	The output remains at the clearcode register value.
Ĺ	1	1	The output remains set according to the DAC register value.
Ĺ	0	1	The output remains at the clearcode register value.
1	ļl	1	The DAC register is loaded with the clearcode register value and the output is set accordingly.
0	ļl	1	The DAC register is loaded with the clearcode register value and the output is set accordingly.
1	t	1	The output remains at the clearcode register value.
0	t	1	The output is set according to the DAC register value.

<sup>1</sup> X is don't care.

#### Table 9. DAC Register

MSB

						LJD
DB23	DB22 DB21 DB20		DB19 to DB2	DB1	DB0	
R/W		Register address		DAC register data		
R/W	0	0	1	18 bits of data	X <sup>1</sup>	X <sup>1</sup>

<sup>1</sup> X is don't care.

#### **Control Register**

The control register controls the mode of operation of the AD5780.

#### **Clearcode Register**

The clearcode register sets the value to which the DAC output is set when the  $\overline{\text{CLR}}$  pin or CLR bit in the software control register

#### Table 10. Control Register

#### MSB

LSB DB23 DB21 DB20 DB19 to DB11 DB10 DB9 DB8 DB4 DB3 DB2 DB1 DB0 DB22 DB7 DB6 DB5 R/W **Register address** Control register data R/W 0 0 Reserved Reserved 0000 SDODIS BIN/2sC DACTRI OPGND RBUF Reserved 1

Table 11. Contr	ol Register Functions
-----------------	-----------------------

Bit Name	Description
Reserved	These bits are reserved and should be programmed to zero.
RBUF	Output amplifier configuration control.
	0: the internal amplifier, A1, is powered up and Resistors R <sub>FB</sub> and R1 are connected in series as shown in Figure 54. This allows an external amplifier to be connected in a gain of two configuration. See the AD5780 Features section for further details. 1: (default) the internal amplifier, A1, is powered down and Resistors R <sub>FB</sub> and R1 are connected in parallel, as shown in Figure 53, so that the resistance between the R <sub>FB</sub> and INV pins is $3.4 k\Omega$ , equal to the resistance of the DAC. This allows the R <sub>FB</sub> and INV pins to be used for input bias current compensation for an external unity-gain amplifier. See the AD5780 Features section for further details.
OPGND	Output ground clamp control.
	0: the DAC output clamp to ground is removed, and the DAC is placed in normal mode.
	1: (default) the DAC output is clamped to ground through a ~6 k $\Omega$ resistance, and the DAC is placed in tristate mode. Resetting the part puts the DAC in OPGND mode, where the output ground clamp is enabled and the DAC is tristated. Setting the OPGND bit to 1 in the control register overrules any write to the DACTRI bit
DACTRI	DAC tristate control.
	0: the DAC is in normal operating mode.
	1: (default) the DAC is in tristate mode.
BIN/2sC	DAC register coding selection.
	0: (default) the DAC register uses twos complement coding.
	1: the DAC register uses offset binary coding.
SDODIS	SDO pin enable/disable control.
	0: (default) the SDO pin is enabled.
	1: the SDO pin is disabled (tristate).
R/W	Read/write select bit.
	0: AD5780 is addressed for a write operation.
	1: AD5780 is addressed for a read operation.

#### Table 12. Clearcode Register

MSB
-----

MSB						LOD
DB23	DB22	DB21	DB20	DB19 to DB2	DB1	DB0
R/W		Register address		Clearcode register data		
R/W	0	1	1	18 bits of data	X <sup>1</sup>	X <sup>1</sup>

<sup>1</sup> X is don't care.

is asserted. The output value depends on the DAC coding that is being used, either binary or twos complement. The default register value is 0.

#### Software Control Register

This is a write only register in which writing a 1 to a particular bit has the same effect as pulsing the corresponding pin low.

#### Table 13. Software Control Register

#### MSB

MSB							LSB
DB23	DB22	DB21	DB20	DB19 to DB3	DB2	DB1	DB0
R/W	Register address		Software control register data				
0	1	0	0	Reserved	Reset	CLR <sup>1</sup>	LDAC <sup>2</sup>

<sup>1</sup> The CLR function has no effect when the  $\overline{LDAC}$  pin is low.

 $^2$  The LDAC function has no effect when the  $\overline{\text{CLR}}$  pin is low.

#### **Table 14. Software Control Register Functions**

Bit Name	Description
LDAC	Setting this bit to 1 updates the DAC register and consequently the DAC output.
CLR	Setting this bit to 1 sets the DAC register to a user defined value (see Table 12) and updates the DAC output. The output value depends on the DAC register coding that is being used, either binary or twos complement.
Reset	Setting this bit to 1 returns the AD5780 to its power-on state.

## AD5780 FEATURES POWER-ON TO 0 V

The AD5780 contains a power-on reset circuit that, as well as resetting all registers to their default values, controls the output voltage during power-up. Upon power-on, the DAC is placed in tristate (its reference inputs are disconnected), and its output is clamped to AGND through a ~6 k $\Omega$  resistor. The DAC remains in this state until programmed otherwise via the control register. This is a useful feature in applications where it is important to know the state of the DAC output while it is in the process of powering up.

## **CONFIGURING THE AD5780**

After power-on, the AD5780 must be configured to put it into normal operating mode before programming the output. To do this, the control register must be programmed. The DAC is removed from tristate by clearing the DACTRI bit, and the output clamp is removed by clearing the OPGND bit. At this point, the output goes to  $V_{REFN}$  unless an alternative value is first programmed to the DAC register.

## DAC OUTPUT STATE

The DAC output can be placed in one of three states, controlled by the DACTRI and OPGND bits of the control register, as shown in Table 15.

#### Table 15. Output State Truth Table

	-	
DACTRI	OPGND	Output State
0	0	Normal operating mode.
0	1	Output is clamped via ~6 k $\Omega$ to AGND.
1	0	Output is in tristate.
1	1	Output is clamped via ~6 k $\Omega$ to AGND.

## **OUTPUT AMPLIFIER CONFIGURATION**

There are a number of different ways that an output amplifier can be connected to the AD5780, depending on the voltage references applied and the desired output voltage span.

## Unity-Gain Configuration

Figure 52 shows an output amplifier configured for unity gain. In this configuration, the output spans from  $V_{REFN}$  to  $V_{REFP}$ .

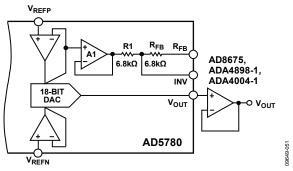


Figure 52. Output Amplifier in Unity-Gain Configuration

A second unity-gain configuration for the output amplifier is one that removes an offset from the input bias currents of the amplifier. It does this by inserting a resistance in the feedback path of the amplifier that is equal to the output resistance of the DAC. The DAC output resistance is  $3.4 \text{ k}\Omega$ . By connecting R1 and R<sub>FB</sub> in parallel, a resistance equal to the DAC resistance is available on chip. Because the resistors are all on one piece of silicon, they are temperature coefficient matched. To enable this mode of operation, the RBUF bit of the control register must be set to Logic 1. Figure 53 shows how the output amplifier is connected to the AD5780. In this configuration, the output amplifier is in unity gain and the output spans from V<sub>REFN</sub> to V<sub>REFP</sub>. This unity-gain configuration allows a capacitor to be placed in the amplifier feedback path to improve dynamic performance.

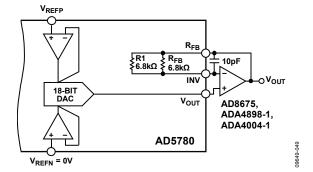


Figure 53. Output Amplifier in Unity Gain with Amplifier Input Bias Current Compensation

## Gain of Two Configuration (×2 Gain Mode)

Figure 54 shows an output amplifier configured for a gain of two. The gain is set by the internal matched 6.8 k $\Omega$  resistors, which are exactly twice the DAC resistance, having the effect of removing an offset from the input bias current of the external amplifier. In this configuration, the output spans from  $2 \times V_{REFN} - V_{REFP}$  to  $V_{REFP}$ . This configuration is used to generate a bipolar output span from a single-ended reference input, with  $V_{REFN} = 0$  V. For this mode of operation, the RBUF bit of the control register must be cleared to Logic 0.

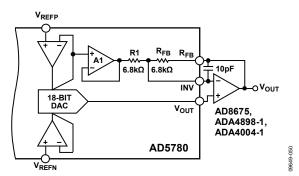


Figure 54. Output Amplifier in Gain-of-Two Configuration

## AD5780

## APPLICATIONS INFORMATION TYPICAL OPERATING CIRCUIT

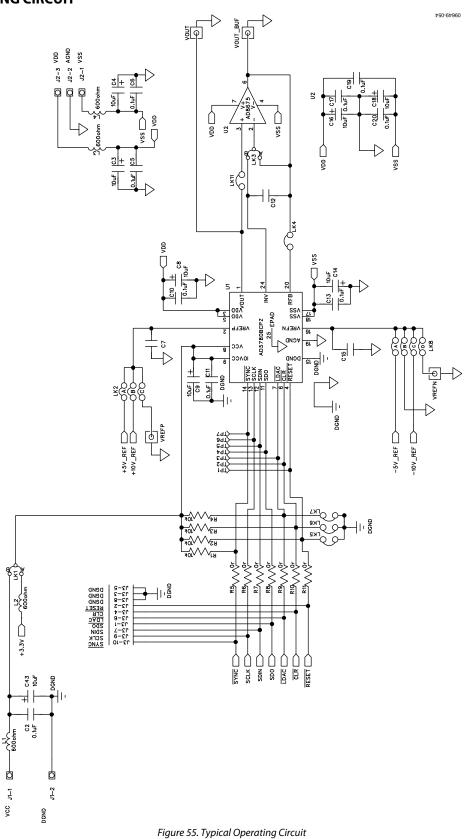


Figure 55 shows a typical operating circuit for the AD5780 using an AD8675 as an output buffer. Because the output impedance of the AD5780 is  $3.4 \text{ }\Omega$ , an output buffer is required for driving low resistive, high capacitive loads.

### **EVALUATION BOARD**

An evaluation board is available for the AD5780 to aid designers in evaluating the high performance of the part with minimum effort. The AD5780 evaluation kit includes a

populated and tested AD5780 printed circuit board (PCB). The evaluation board interfaces to the USB port of a PC. Software is available with the evaluation board to allow the user to easily program the AD5780. The software runs on any PC that has Microsoft<sup>®</sup> Windows<sup>®</sup> XP (SP2), Vista (32-bit or 64-bit), or Windows 7 installed. The AD5780 user guide, UG-256, is available, which gives full details on the operation of the evaluation board.

# **OUTLINE DIMENSIONS**

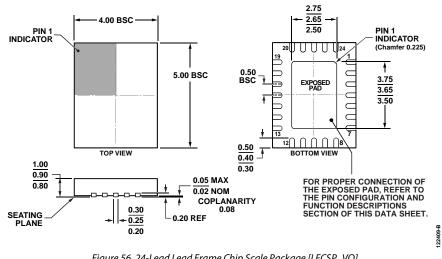


Figure 56. 24-Lead Lead Frame Chip Scale Package [LFCSP\_VQ] 4 mm × 5 mm Body, Very Thin Quad (CP-24-5) Dimensions shown in millimeters

### **ORDERING GUIDE**

Model <sup>1</sup>	Temperature Range	INL	Package Description	Package Option
AD5780ACPZ	-40°C to +125°C	±2 LSB	24-Lead LFCSP_VQ	CP-24-5
AD5780ACPZ-REEL7	-40°C to +125°C	±2 LSB	24-Lead LFCSP_VQ	CP-24-5
AD5780BCPZ	–40°C to +125°C	±1 LSB	24-Lead LFCSP_VQ	CP-24-5
AD5780BCPZ-REEL7	-40°C to +125°C	±1 LSB	24-Lead LFCSP_VQ	CP-24-5
EVAL-AD5780SDZ			Evaluation Board	

 $^{1}$  Z = RoHS Compliant Part.

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